

March 2008

# FDD8451

# N-Channel PowerTrench<sup>®</sup> MOSFET 40V, 28A, $24m\Omega$

#### **Features**

- Max  $r_{DS(on)} = 24m\Omega$  at  $V_{GS} = 10V$ ,  $I_D = 9A$
- Max  $r_{DS(on)} = 30m\Omega$  at  $V_{GS} = 4.5V$ ,  $I_D = 7A$
- Low gate charge
- Fast Switching
- High performance trench technology for extremely low r<sub>DS(on)</sub>
- RoHS compliant

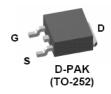


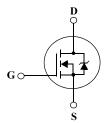
#### **General Description**

This N-Channel MOSFET has been designed specifically to improve the overall efficiency of DC/DC converters using either synchronous or conventional switching PWM controllers. It has been optimized for low gate charge, fast switching speed and extremely low  $r_{DS(on)}. \label{eq:posterior}$ 

# **Application**

- DC/DC converter
- Backlight inverter





# MOSFET Maximum Ratings T<sub>C</sub> = 25°C unless otherwise noted

Symbol	Parameter		Ratings	Units
$V_{DS}$	Drain to Source Voltage		40	V
$V_{GS}$	Gate to Source Voltage		±20	V
	Drain Current -Continuous @T <sub>C</sub> =25°C		28	
$I_D$	-Continuous @T <sub>A</sub> =25°C		9	Α
	-Pulsed (N	ote 1)	78	
E <sub>AS</sub>	Single Pulse Avalanche Energy (N	ote 2)	20	mJ
$P_{D}$	Power Dissipation		37	W
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Temperature	-	55 to 150	°C

#### **Thermal Characteristics**

$R_{\theta JC}$	Thermal Resistance, Junction to Case	4.1	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	40	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	96	°C/W

# **Package Marking and Ordering Information**

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDD8451	FDD8451	D-PAK(TO-252)	13"	12mm	2500 units

# **Electrical Characteristics** $T_J = 25^{\circ}C$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Chara	cteristics					
$BV_{DSS}$	Drain to Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	40			V
$\frac{\Delta BV_{DSS}}{\Delta T_{J}}$	Breakdown Voltage Temperature Coefficient	I <sub>D</sub> = 250μA, referenced to 25°C		33.5		mV/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> = 32V, V <sub>GS</sub> = 0V			1	μА
I <sub>GSS</sub>	Gate to Source Leakage Current	$V_{GS} = \pm 20V, V_{DS} = 0V$			±100	nA

#### **On Characteristics**

$V_{GS(th)}$	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_{D} = 250 \mu A$	1	2.1	3	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	$I_D$ = 250 $\mu$ A, referenced to 25°C		-5.7		mV/°C
		V <sub>GS</sub> = 10V, I <sub>D</sub> = 9A		19	24	
rpo()	Drain to Source On Resistance	$V_{GS} = 4.5V, I_D = 7A$		23	30	mΩ
r <sub>DS(on)</sub> Drain to Source On Resistance	$V_{GS} = 10V, I_D = 9A$ $T_J = 150$ °C		32	41	11132	
g <sub>FS</sub>	Forward Transcondductance	V <sub>DS</sub> = 5V, I <sub>D</sub> = 9A		29		S

## **Dynamic Characteristics**

C <sub>iss</sub>	Input Capacitance	V - 20V V - 0V	780	990	pF
Coss	Output Capacitance	V <sub>DS</sub> = 20V, V <sub>GS</sub> = 0V, f = 1MHz	112	150	pF
C <sub>rss</sub>	Reverse Transfer Capacitance	1 - 1101112	72	110	pF
R <sub>a</sub>	Gate Resistance	f = 1MHz	1.1		Ω

### **Switching Characteristics**

$t_{d(on)}$	Turn-On Delay Time		7	14	ns
t <sub>r</sub>	Rise Time	$V_{DD} = 20V, I_D = 9A$ $V_{GS} = 10V, R_{GEN} = 6\Omega$	3	10	ns
t <sub>d(off)</sub>	Turn-Off Delay Time	V <sub>GS</sub> = 10V, R <sub>GEN</sub> = 002	19	34	ns
t <sub>f</sub>	Fall Time		2	10	ns
$Q_g$	Total Gate Charge at 10V		16	20	nC
$Q_g$	Total Gate Charge at 5V	V <sub>DS</sub> = 20V, I <sub>D</sub> = 9A	8.6	11	nC
$Q_{gs}$	Gate to Source Gate Charge	$V_{DS} = 20V, I_D = 9A$ $V_{GS} = 10V$	2.5		nC
$Q_{gd}$	Gate to Drain "Miller" Charge		3.7		nC

#### **Drain-Source Diode Characteristics**

$V_{SD}$	Source to Drain Diode Forward Voltage	$V_{GS} = 0V, I_{S} = 9A$	0.87	1.2	V
t <sub>rr</sub>	Reverse Recovery Time	$I_F = 9A$ , di/dt = 100A/ $\mu$ s	25	38	ns
Q <sub>rr</sub>	Reverse Recovery Charge	I <sub>F</sub> = 9A, di/dt = 100A/μs	19	29	nC

Pulse time < 300µs, Duty cycle = 2%.</li>
 Starting T<sub>J</sub> = 25°C, L = 0.1mH, I<sub>AS</sub> = 20A, V<sub>DD</sub> = 36V, V<sub>GS</sub> = 10V.

#### Typical Characteristics T<sub>J</sub> = 25°C unless otherwise noted

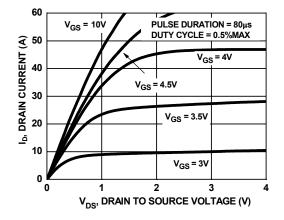


Figure 1. On Region Characteristics

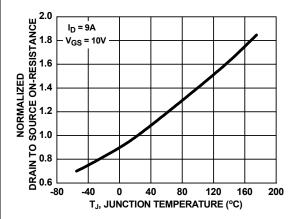


Figure 3. Normalized On Resistance vs Junction Temperature

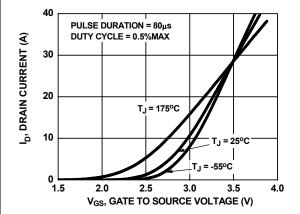


Figure 5. Transfer Characteristics

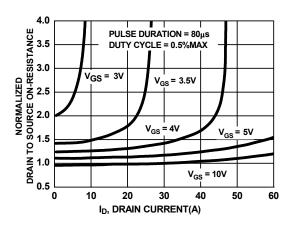


Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage

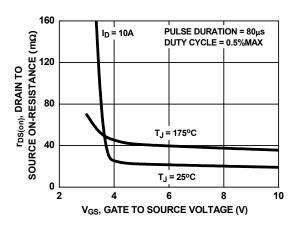


Figure 4. On-Resistance vs Gate to Source Voltage

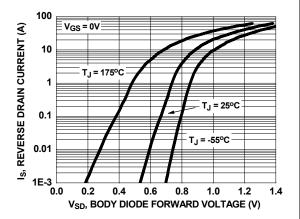
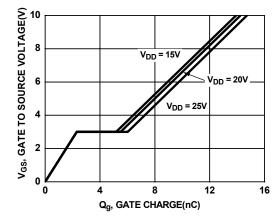


Figure 6. Source to Drain Diode Forward Voltage vs Source Current

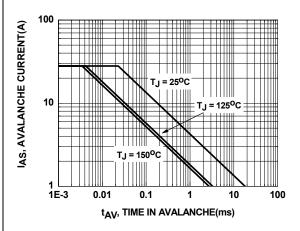
# Typical Characteristics $T_J = 25^{\circ}C$ unless otherwise noted



3000 | C<sub>iss</sub> | C<sub>oss</sub> | C<sub>oss</sub> | C<sub>rss</sub> | C<sub>rss</sub> | C<sub>oss</sub> | C<sub>oss</sub>

Figure 7. Gate Charge Characteristics

Figure 8. Capacitance vs Drain to Source Voltage



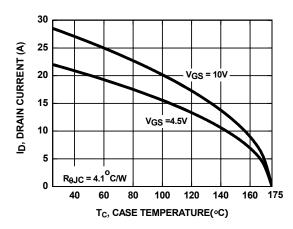
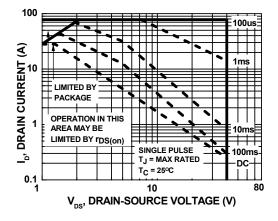


Figure 9. Unclamped Inductive Switching Capability

Figure 10. Maximum Continuous Drain Current vs Case Temperature



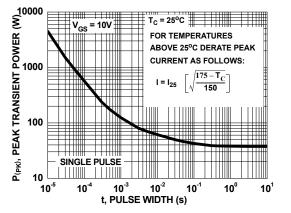


Figure 11. Forward Bias Safe Operating Area

Figure 12. Single Pulse Maximum Power Dissipation



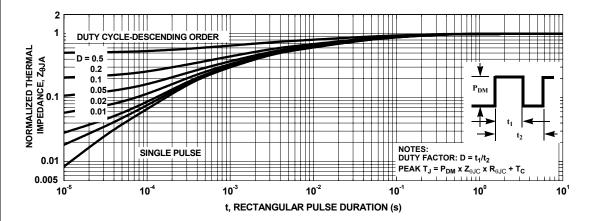


Figure 13. Transient Thermal Response Curve





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